

FDZ209N

60V N-Channel PowerTrench® BGA MOSFET

General Description

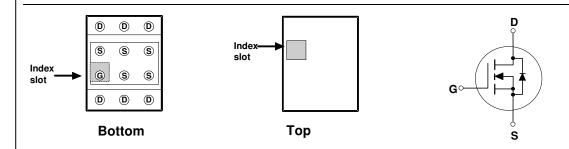
Combining Fairchild's advanced PowerTrench process with state-of-the-art BGA packaging, the FDZ209N minimizes both PCB space and $R_{\rm DS(ON)}.$ This BGA MOSFET embodies a breakthrough in packaging technology which enables the device to combine excellent thermal transfer characteristics, high current handling capability, ultra-low profile packaging, low gate charge, and low $R_{\rm DS(ON)}.$

Applications

· Solenoid Drivers

Features

- 4 A, 60 V. $R_{DS(ON)} = 80 \text{ m}\Omega$ @ $V_{GS} = 5 \text{ V}$
- Occupies only 5 mm² of PCB area: only 55% of the area of SSOT-6
- Ultra-thin package: less than 0.80 mm height when mounted to PCB
- Outstanding thermal transfer characteristics: 4 times better than SSOT-6
- $\bullet \ \ Ultra\text{-low} \ Q_g \ x \ R_{DS(ON)} \ figure\text{-of-merit} \\$
- · High power and current handling capability



Absolute Maximum Ratings T_A=25°C unless otherwise noted

Symbol	Parameter		Ratings	Units
V_{DSS}	Drain-Source Voltage		60	V
V_{GSS}	Gate-Source Voltage		±20	V
I _D	Drain Current - Continuous	(Note 1a)	4	A
	Pulsed		20	
P _D	Power Dissipation (Steady State)	(Note 1a)	2	W
T _J , T _{STG}	Operating and Storage Junction Tempe	rature Range	-55 to +150	°C

Thermal Characteristics

$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	(Note 1a)	64	°C/W
$R_{\theta JB}$	Thermal Resistance, Junction-to-Ball	(Note 1)	8	
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	(Note 1)	0.7	

Package Marking and Ordering Information

Device Marking	Device	Reel Size	Tape width	Quantity
209N	FDZ209N	7"	8mm	3000 units

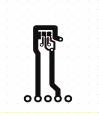
Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Drain-So	ource Avalanche Ratings (Note	e 2)	1		I.	l
W _{DSS}	Drain-Source Avalanche Energy	Single Pulse, $V_{DD} = 30 \text{ V}$,			90	mJ
I _{AR}	Drain-Source Avalanche Current	I _D = 4 A			4	Α
Off Char	acteristics		1	I.	ı	
BV _{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, \qquad I_{D} = 250 \mu\text{A}$	60			V
ΔBV _{DSS} ΔT _J	Breakdown Voltage Temperature Coefficient	I_D = 250 μ A, Referenced to 25°C		59		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 48 \text{ V}, \qquad V_{GS} = 0 \text{ V}$			1	μΑ
I _{GSS}	Gate-Body Leakage.	$V_{GS} = \pm 20 \text{ V}, \qquad V_{DS} = 0 \text{ V}$			±100	nA
	acteristics (Note 2)					
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS},$ $I_{D} = 250 \mu\text{A}$	1	2.5	3	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate Threshold Voltage Temperature Coefficient	I_D = 250 μ A, Referenced to 25°C		-6		mV/°C
$R_{\text{DS}(\text{on})}$	Static Drain–Source On–Resistance	V _{GS} = 5 V, I _D = 4 A V _{GS} = 5 V, I _D = 4 A, T _J =125°C		60 91	80 130	mΩ
g _{FS}	Forward Transconductance	$V_{GS} = 5 \text{ V}, I_D = 4 \text{ A}, T_J = 125^{\circ}\text{C}$ $V_{DS} = 5 \text{ V}, I_D = 4 \text{ A}$		12	100	S
	Characteristics	-		•	•	•
C _{iss}	Input Capacitance	$V_{DS} = 30 \text{ V}, \qquad V_{GS} = 0 \text{ V},$		657		pF
Coss	Output Capacitance	f = 1.0 MHz		76		pF
C _{rss}	Reverse Transfer Capacitance]		32		pF
R _G	Gate Resistance	$V_{GS} = 15 \text{ mV}, f = 1.0 \text{ MHz}$		1.5		Ω
Switchin	g Characteristics (Note 2)					
t _{d(on)}	Turn-On Delay Time	$V_{DD} = 30 \text{ V}, \qquad I_{D} = 1 \text{ A},$		18	32	ns
t _r	Turn-On Rise Time	$V_{GS} = 5 \text{ V}, \qquad R_{GEN} = 6 \Omega$		4	8	ns
t _{d(off)}	Turn-Off Delay Time	1		15	27	ns
t _f	Turn-Off Fall Time	1		8	16	ns
Q _g	Total Gate Charge	$V_{DS} = 30 \text{ V}, \qquad I_{D} = 4 \text{ A},$		6.3	9	nC
Q _{gs}	Gate-Source Charge	$V_{GS} = 5 \text{ V}$		2.5		nC
Q_{gd}	Gate-Drain Charge	1		2.5		nC
Drain-Sc	ource Diode Characteristics	and Maximum Ratings	•			
Is	Maximum Continuous Drain-Source	<u>~</u>			1.7	Α
V _{SD}	Drain-Source Diode Forward Voltage	$V_{GS} = 0 \text{ V}, I_S = 1.7 \text{ A} \text{(Note 2)}$		0.77	1.2	V
t _{rr}	Diode Reverse Recovery Time	$I_F = 4A$		27		nS
Q _{rr}	Diode Reverse Recovery Charge	$d_{iF}/d_t = 100 \text{ A}/\mu\text{s} \qquad \qquad \text{(Note 2)}$	_	45		nC

Notes:

1. R_{BJA} is determined with the device mounted on a 1 in² 2 oz. copper pad on a 1.5 x 1.5 in. board of FR-4 material. The thermal resistance from the junction to the thermal reference point for the case is defined as the top surface of the the circuit board side of the solder ball, R_{e,JB}, is defined for reference. For R_{e,JC}, the thermal reference point for the case is defined as the top surface of the copper chip carrier. $R_{\theta,JC}$ and $R_{\theta,JB}$ are guaranteed by design while $R_{\theta,JA}$ is determined by the user's board design.



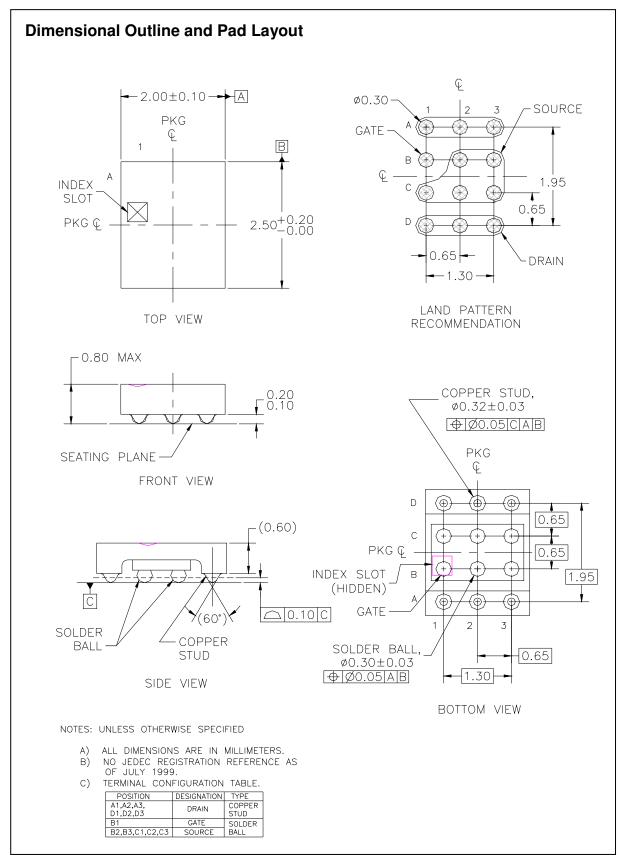
64℃/W when mounted on a 1in² pad of 2 oz copper, 1.5" x 1.5" x 0.062" thick PCB



b) 128 ℃/W when mounted on a minimum pad of 2 oz copper

Scale 1:1 on letter size paper

Pulse Test: Pulse Width < 300µs, Duty Cycle < 2.0%



Typical Characteristics

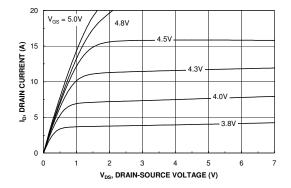


Figure 1. On-Region Characteristics.

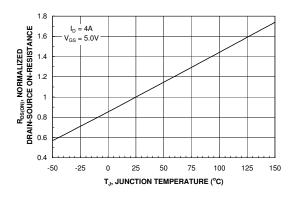


Figure 3. On-Resistance Variation with Temperature.

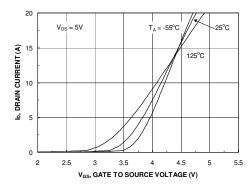


Figure 5. Transfer Characteristics.

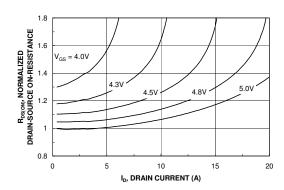


Figure 2. On-Resistance Variation with Drain Current and Gate Voltage.

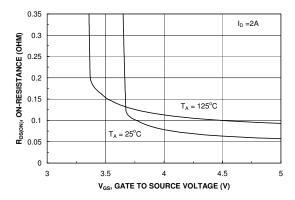


Figure 4. On-Resistance Variation with Gate-to-Source Voltage.

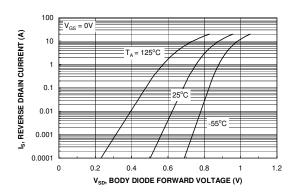
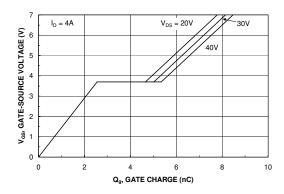


Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.

Typical Characteristics



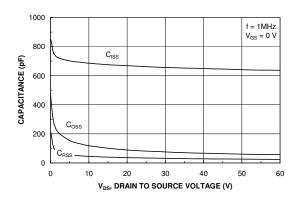
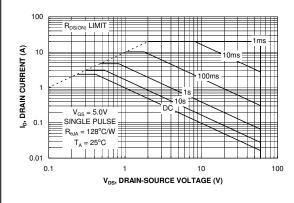


Figure 7. Gate Charge Characteristics.





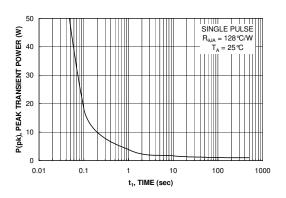


Figure 9. Maximum Safe Operating Area.

Figure 10. Single Pulse Maximum Power Dissipation.

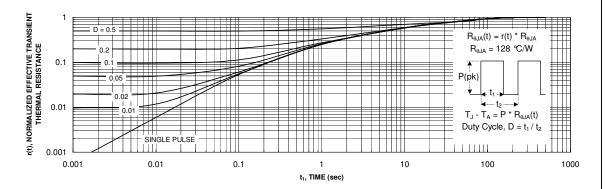


Figure 11. Transient Thermal Response Curve.

Thermal characterization performed using the conditions described in Note 1b. Transient thermal response will change depending on the circuit board design.

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